

# Boost Converter Stage in APM16 Series for Multiphase and Semi-Bridgeless PFC with SiC Diodes



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## FAM65CR51ADZ1, FAM65CR51ADZ2

### Features

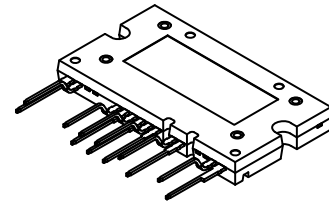
- Integrated SIP or DIP Boost Converter Stage Power Module for On-board Charger (OBC) in EV or PHEV
- 5 kV/1 sec Electrically Isolated Substrate for Easy Assembly
- Creepage and Clearance per IEC60664-1, IEC 60950-1
- Compact Design for Low Total Module Resistance
- Module Serialization for Full Traceability
- Lead Free, RoHS and UL94V-0 Compliant
- Automotive Qualified per AEC Q101 and AQC324 Guidelines
- Improved Performance with SiC Diodes

### Applications

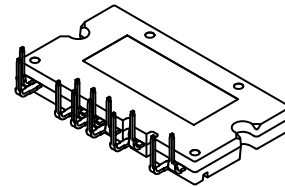
- PFC Stage of an On-board Charger in PHEV or EV

### Benefits

- Enable Design of Small, Efficient and Reliable System for Reduced Vehicle Fuel Consumption and CO<sub>2</sub> Emission
- Simplified Assembly, Optimized Layout, High Level of Integration, and Improved Thermal Performance

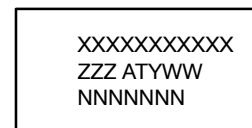


APMCD-A16  
12 LEAD  
CASE MODGG



APMCD-B16  
12 LEAD  
CASE MODGK

### MARKING DIAGRAM



XXXX = Specific Device Code  
ZZZ = Lot ID  
AT = Assembly & Test Location  
Y = Year  
W = Work Week  
NNN = Serial Number

### ORDERING INFORMATION

See detailed ordering, marking and shipping information on page 2 of this data sheet.

# FAM65CR51ADZ1, FAM65CR51ADZ2

## ORDERING INFORMATION

| Part Number   | Package   | Lead Forming | DBC Material                   | Pb-Free and RoHS Compliant | Operating Temperature (T <sub>A</sub> ) | Packing Method |
|---------------|-----------|--------------|--------------------------------|----------------------------|---|----------------|
| FAM65CR51ADZ1 | APM16-CDA | Y-Shape      | Al <sub>2</sub> O <sub>3</sub> | Yes                        | -40°C ~ 125°C                           | Tube           |
| FAM65CR51ADZ2 | APM16-CDB | L-Shape      | Al <sub>2</sub> O <sub>3</sub> | Yes                        | -40°C ~ 125°C                           | Tube           |

## Pin Configuration and Description

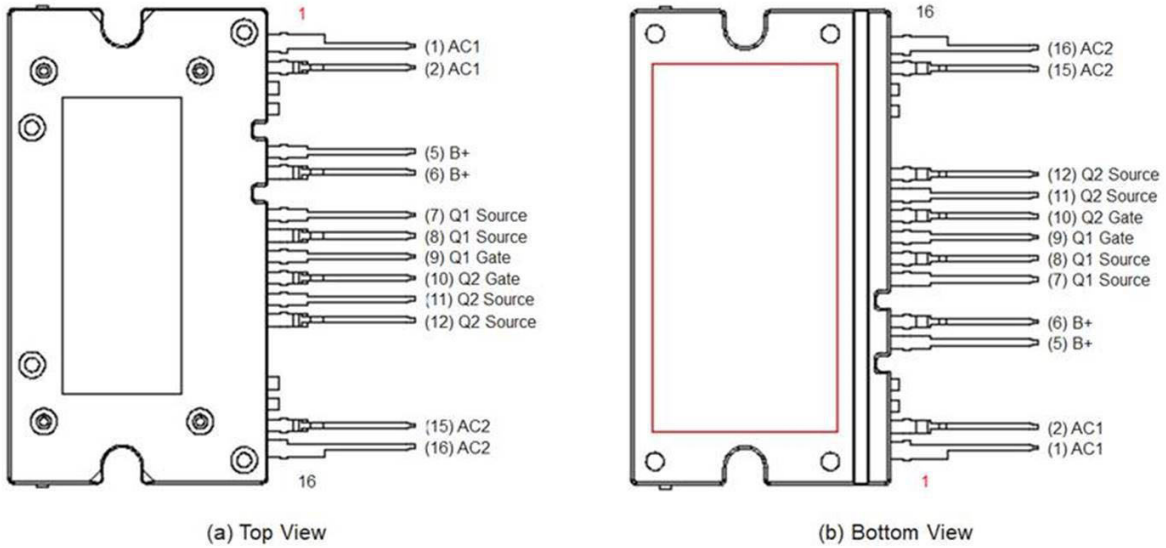


Figure 1. Pin Configuration

Table 1. PIN DESCRIPTION

| Pin Number | Pin Name  | Pin Description               |
|------------|-----------|-------------------------------|
| 1, 2       | AC1       | Phase 1 Leg of the PFC Bridge |
| 3          | NC        | Not Connected                 |
| 4          | NC        | Not Connected                 |
| 5, 6       | B+        | Positive Battery Terminal     |
| 7, 8       | Q1 Source | Source Terminal of Q1         |
| 9          | Q1 Gate   | Gate Terminal of Q1           |
| 10         | Q2 Gate   | Gate Terminal of Q2           |
| 11, 12     | Q2 Source | Source Terminal of Q2         |
| 13         | NC        | Not Connected                 |
| 14         | NC        | Not Connected                 |
| 15, 16     | AC2       | Phase 2 Leg of the PFC Bridge |

# FAM65CR51ADZ1, FAM65CR51ADZ2

## INTERNAL EQUIVALENT CIRCUIT

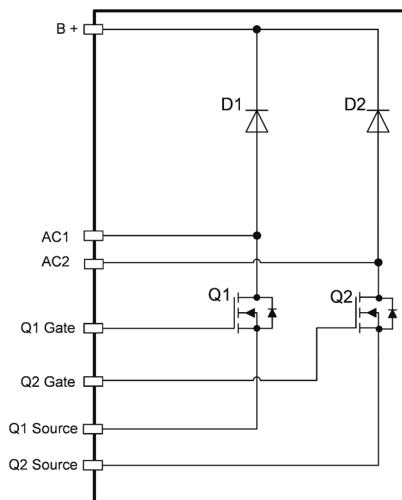


Figure 2. Internal Block Diagram

Table 2. ABSOLUTE MAXIMUM RATINGS OF MOSFET ( $T_J = 25^\circ\text{C}$ , Unless Otherwise Specified)

| Symbol           | Parameter  | Max         | Unit             |
|------------------|--|-------------|------------------|
| $V_{DS}$ (Q1~Q2) | Drain-to-Source Voltage  | 650         | V                |
| $V_{GS}$ (Q1~Q2) | Gate-to-Source Voltage   | $\pm 20$    | V                |
| $I_D$ (Q1~Q2)    | Drain Current Continuous ( $T_C = 25^\circ\text{C}$ , $V_{GS} = 10\text{ V}$ ) (Note 1)  | 41          | A                |
|                  | Drain Current Continuous ( $T_C = 100^\circ\text{C}$ , $V_{GS} = 10\text{ V}$ ) (Note 1) | 25          | A                |
| $E_{AS}$ (Q1~Q2) | Single Pulse Avalanche Energy (Note 2)   | 623         | mJ               |
| $P_D$            | Power Dissipation (Note 1)   | 189         | W                |
| $T_J$            | Maximum Junction Temperature   | -55 to +150 | $^\circ\text{C}$ |
| $T_C$            | Maximum Case Temperature   | -40 to +125 | $^\circ\text{C}$ |
| $T_{STG}$        | Storage Temperature  | -40 to +125 | $^\circ\text{C}$ |

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. Maximum continuous current and power, without switching losses, to reach  $T_J = 150^\circ\text{C}$  respectively at  $T_C = 25^\circ\text{C}$  and  $T_C = 100^\circ\text{C}$ ; defined by design based on MOSFET  $R_{DS(ON)}$  and  $R_{\theta JC}$  and not subject to production test
2. Starting  $T_J = 25^\circ\text{C}$ ,  $I_{AS} = 6.5\text{ A}$ ,  $R_G = 25\ \Omega$

### DBC Substrate

0.63 mm Al<sub>2</sub>O<sub>3</sub> alumina with 0.3 mm copper on both sides.  
DBC substrate is NOT nickel plated.

### Lead Frame

OFC copper alloy, 0.50 mm thick. Plated with 8  $\mu\text{m}$  to 25.4  $\mu\text{m}$  thick Matte Tin

### Flammability Information

All materials present in the power module meet UL flammability rating class 94V-0.

### Compliance to RoHS Directives

The power module is 100% lead free and RoHS compliant 2000/53/C directive.

### Solder

Solder used is a lead free SnAgCu alloy.

Solder presents high risk to melt at temperature beyond 210 $^\circ\text{C}$ . Base of the leads, at the interface with the package body, should not be exposed to more than 200 $^\circ\text{C}$  during mounting on the PCB or during welding to prevent the re-melting of the solder joints.

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**Table 3. ELECTRICAL SPECIFICATIONS OF MOSFET** ( $T_J = 25^\circ\text{C}$ , Unless Otherwise Specified)

| Symbol          | Parameter                         | Conditions  | Min  | Typ | Max  | Unit             |
|-----------------|-----------------------------------|---|------|-----|------|------------------|
| $BV_{DSS}$      | Drain-to-Source Breakdown Voltage | $I_D = 1\text{ mA}, V_{GS} = 0\text{ V}$                                    | 650  | –   | –    | V                |
| $V_{GS(th)}$    | Gate-to-Source Threshold Voltage  | $V_{GS} = V_{DS}, I_D = 3.3\text{ mA}$                                      | 3.0  | –   | 5.0  | V                |
| $R_{DS(ON)} Q1$ | Q1 Low Side MOSFET                | $V_{GS} = 10\text{ V}, I_D = 20\text{ A}$                                   | –    | 44  | 51   | $\text{m}\Omega$ |
| $R_{DS(ON)} Q2$ | Q2 Low Side MOSFET                |   | –    | 44  | 51   | $\text{m}\Omega$ |
| $R_{DS(ON)} Q1$ | Q1 Low Side MOSFET                | $V_{GS} = 10\text{ V}, I_D = 20\text{ A}, T_J = 125^\circ\text{C}$ (Note 3) | –    | 79  | –    | $\text{m}\Omega$ |
| $R_{DS(ON)} Q2$ | Q2 Low Side MOSFET                |   | –    | 79  | –    | $\text{m}\Omega$ |
| $g_{FS}$        | Forward Transconductance          | $V_{DS} = 20\text{ V}, I_D = 20\text{ A}$ (Note 3)                          | –    | 30  | –    | S                |
| $I_{GSS}$       | Gate-to-Source Leakage Current    | $V_{GS} = \pm 20\text{ V}, V_{DS} = 0\text{ V}$                             | –100 | –   | +100 | nA               |
| $I_{DSS}$       | Drain-to-Source Leakage Current   | $V_{DS} = 650\text{ V}, V_{GS} = 0\text{ V}$                                | –    | –   | 10   | $\mu\text{A}$    |

### DYNAMIC CHARACTERISTICS (Note 3)

|                |                               |  |   |      |   |          |
|----------------|-------------------------------|--|---|------|---|----------|
| $C_{iss}$      | Input Capacitance             | $V_{DS} = 400\text{ V}$<br>$V_{GS} = 0\text{ V}$<br>$f = 1\text{ MHz}$               | – | 4864 | – | pF       |
| $C_{oss}$      | Output Capacitance            |  | – | 109  | – | pF       |
| $C_{rss}$      | Reverse Transfer Capacitance  |  | – | 16   | – | pF       |
| $C_{oss(eff)}$ | Effective Output Capacitance  | $V_{DS} = 0\text{ to }520\text{ V}$<br>$V_{GS} = 0\text{ V}$                         | – | 652  | – | pF       |
| $R_g$          | Gate Resistance               | $f = 1\text{ MHz}$   | – | 2    | – | $\Omega$ |
| $Q_{g(tot)}$   | Total Gate Charge             | $V_{DS} = 380\text{ V}$<br>$I_D = 20\text{ A}$<br>$V_{GS} = 0\text{ to }10\text{ V}$ | – | 123  | – | nC       |
| $Q_{gs}$       | Gate-to-Source Gate Charge    |  | – | 37.5 | – | nC       |
| $Q_{gd}$       | Gate-to-Drain "Miller" Charge |  | – | 49   | – | nC       |

### SWITCHING CHARACTERISTICS (Note 3)

|              |                     |  |   |     |   |    |
|--------------|---------------------|--|---|-----|---|----|
| $t_{on}$     | Turn-on Time        | $V_{DS} = 400\text{ V}$<br>$I_D = 20\text{ A}$<br>$V_{GS} = 10\text{ V}$<br>$R_G = 4.7\text{ Ohm}$ | – | 87  | – | ns |
| $t_{d(on)}$  | Turn-on Delay Time  |  | – | 47  | – | ns |
| $t_r$        | Turn-on Rise Time   |  | – | 43  | – | ns |
| $t_{off}$    | Turn-off Time       |  | – | 146 | – | ns |
| $t_{d(off)}$ | Turn-off Delay Time |  | – | 118 | – | ns |
| $t_f$        | Turn-off Fall Time  |  | – | 29  | – | ns |

### BODY DIODE CHARACTERISTICS

|          |                               |  |   |      |   |    |
|----------|-------------------------------|--|---|------|---|----|
| $V_{SD}$ | Source-to-Drain Diode Voltage | $I_{SD} = 20\text{ A}, V_{GS} = 0\text{ V}$  | – | 0.95 | – | V  |
| $T_{rr}$ | Reverse Recovery Time         | $V_{DS} = 520\text{ V}, I_D = 20\text{ A},$<br>$dI/dt = 100\text{ A}/\mu\text{s}$ (Note 3) | – | 133  | – | ns |
| $Q_{rr}$ | Reverse Recovery Charge       |  | – | 669  | – | nC |

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

3. Defined by design, not subject to production test

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**Table 4. ABSOLUTE MAXIMUM RATINGS OF THE BOOST DIODE** ( $T_J = 25^\circ\text{C}$ , Unless Otherwise Specified)

| Symbol      | Parameter  | Rating      | Unit             |
|-------------|--|-------------|------------------|
| $V_{RRM}$   | Peak Repetitive Reverse Voltage (Note 4)   | 650         | V                |
| $E_{AS}$    | Avalanche Energy (17 A, 1 mH)  | 144         | mJ               |
| $I_F$       | Continuous Rectified Forward Current, $T_C < 148^\circ\text{C}$                    | 30          | A                |
| $I_{F,MAX}$ | Non-Repetitive Forward Surge Current, $T_C = 25^\circ\text{C}$ , 10 $\mu\text{s}$  | 1100        | A                |
| $I_{F,MAX}$ | Non-Repetitive Forward Surge Current, $T_C = 150^\circ\text{C}$ , 10 $\mu\text{s}$ | 1000        | A                |
| $I_{FSM}$   | Non-Repetitive Peak Surge Current (Sine Half Wave, $T_p = 8.3$ ms)                 | 110         | A                |
| $P_D$       | Power Dissipation ( $T_C = 25^\circ\text{C}$ )                                     | 65          | W                |
| $T_J$       | Maximum Junction Temperature   | -55 to +175 | $^\circ\text{C}$ |
| $T_C$       | Maximum Case Temperature   | -40 to +125 | $^\circ\text{C}$ |
| $T_{STG}$   | Storage Temperature  | -40 to +125 | $^\circ\text{C}$ |

4.  $V_{RRM}$  and  $I_F$  value referenced to TO220-2L Auto Qualified Package Device FFSP3065B\_F085

**Table 5. ELECTRICAL SPECIFICATIONS OF THE BOOST DIODE** ( $T_J = 25^\circ\text{C}$ , Unless Otherwise Specified)

| Symbol   | Parameter                     | Test Conditions         |                           | Min | Typ  | Max | Unit          |
|----------|-------------------------------|-------------------------|---------------------------|-----|------|-----|---------------|
| $V_{DC}$ | DC Blocking Voltage           | $I_R = 200 \mu\text{A}$ | $T_C = 25^\circ\text{C}$  | 650 | -    | -   | V             |
| $V_F$    | Instantaneous Forward Voltage | $I_F = 30$ A            | $T_C = 25^\circ\text{C}$  | -   | 1.38 | 1.7 | V             |
|          |                               |                         | $T_C = 125^\circ\text{C}$ | -   | 1.6  | 2.0 | V             |
|          |                               |                         | $T_C = 175^\circ\text{C}$ | -   | 1.72 | 2.4 | V             |
| $I_R$    | Instantaneous Reverse Current | $V_R = 650$ V           | $T_C = 25^\circ\text{C}$  | -   | 0.5  | 40  | $\mu\text{A}$ |
|          |                               |                         | $T_C = 125^\circ\text{C}$ | -   | 1.0  | 80  | $\mu\text{A}$ |
|          |                               |                         | $T_C = 175^\circ\text{C}$ | -   | 2.0  | 160 | $\mu\text{A}$ |
| $Q_C$    | Total Capacitive Charge       | $V_R = 400$ V           | $T_C = 25^\circ\text{C}$  | -   | 43   | -   | nC            |
| C        | Total Capacitance             | $V_R = 1$ V             | $f = 100$ kHz             | -   | 1280 | -   | pF            |
|          |                               | $V_R = 200$ V           | $f = 100$ kHz             | -   | 139  | -   |               |
|          |                               | $V_R = 400$ V           | $f = 100$ kHz             | -   | 108  | -   |               |

**Table 6. THERMAL RESISTANCE**

| Parameters                        |  | Min | Typ  | Max  | Unit                      |
|-----------------------------------|--|-----|------|------|---------------------------|
| $R_{\theta JC}$ (per MOSFET chip) | Q1,Q2 Thermal Resistance Junction-to-Case (Note 5) | -   | 0.47 | 0.66 | $^\circ\text{C}/\text{W}$ |
| $R_{\theta JS}$ (per MOSFET chip) | Q1,Q2 Thermal Resistance Junction-to-Sink (Note 6) | -   | 0.95 | -    | $^\circ\text{C}/\text{W}$ |
| $R_{\theta JC}$ (per DIODE chip)  | D1,D2 Thermal Resistance Junction-to-Case (Note 5) | -   | 1.78 | 2.3  | $^\circ\text{C}/\text{W}$ |
| $R_{\theta JS}$ (per DIODE chip)  | D1,D2 Thermal Resistance Junction-to-Sink (Note 6) | -   | 3.10 | -    | $^\circ\text{C}/\text{W}$ |

5. Test method compliant with MIL STD 883-1012.1, from case temperature under the chip to case temperature measured below the package at the chip center, Cosmetic oxidation and discoloration on the DBC surface allowed

6. Defined by thermal simulation assuming the module is mounted on a 5 mm Al-360 die casting material with 30  $\mu\text{m}$  of 1.8 W/mK thermal interface material

**Table 7. ISOLATION** (Isolation resistance at tested voltage between the base plate and to control pins or power terminals.)

| Test                                 | Test Conditions        | Isolation Resistance | Unit     |
|--------------------------------------|------------------------|----------------------|----------|
| Leakage @ Isolation Voltage (Hi-Pot) | $V_{AC} = 5$ kV, 50 Hz | 100M <               | $\Omega$ |

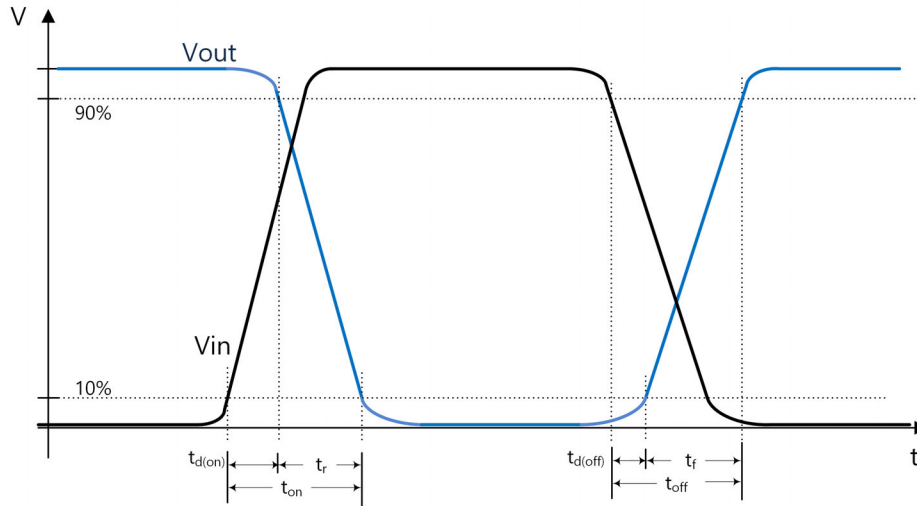
# FAM65CR51ADZ1, FAM65CR51ADZ2

## PARAMETER DEFINITIONS

Reference to Table 3: Parameter of MOSFET Electrical Specifications

|              |  |
|--------------|--|
| $BV_{DSS}$   | <p>Q1, Q2 MOSFET Drain-to-Source Breakdown Voltage</p> <p>The maximum drain-to-source voltage the MOSFET can endure without the avalanche breakdown of the body- drain P-N junction in off state.</p> <p>The measurement conditions are to be found in Table 3.</p> <p>The typ. Temperature behavior is described in Figure 13</p> |
| $V_{GS(th)}$ | <p>Q1, Q2 MOSFET Gate to Source Threshold Voltage</p> <p>The gate-to-source voltage measurement is triggered by a threshold ID current given in conditions at Table 4.</p> <p>The typ. Temperature behavior can be found in Figure 10</p>  |
| $R_{DS(on)}$ | <p>Q1, Q2 MOSFET On Resistance</p> <p><math>R_{DS(on)}</math> is the total resistance between the source and the drain during the on state.</p> <p>The measurement conditions are to be found in Table 3.</p> <p>The typ behavior can be found in Figure 11 and Figure 12 as well as Figure 17</p>                                 |
| $g_{FS}$     | <p>Q1, Q2 MOSFET Forward Transconductance</p> <p>Transconductance is the gain in the MOSFET, expressed in the Equation below.</p> <p>It describes the change in drain current by the change in the gate-source bias voltage: <math>g_{fs} = [\Delta I_{DS} / \Delta V_{GS}]_{V_{DS}}</math></p>                                    |
| $I_{GSS}$    | <p>Q1, Q2 MOSFET Gate-to-Source Leakage Current</p> <p>The current flowing from Gate to Source at the maximum allowed VGS</p> <p>The measurement conditions are described in the Table 3.</p>  |
| $I_{DSS}$    | <p>Q1, Q2 MOSFET Drain-to-Source Leakage Current</p> <p>Drain - Source current is measured in off state while providing the maximum allowed drain-to-source voltage and the gate is shorted to the source.</p> <p><math>I_{DSS}</math> has a positive temperature coefficient.</p>   |

## FAM65CR51ADZ1, FAM65CR51ADZ2



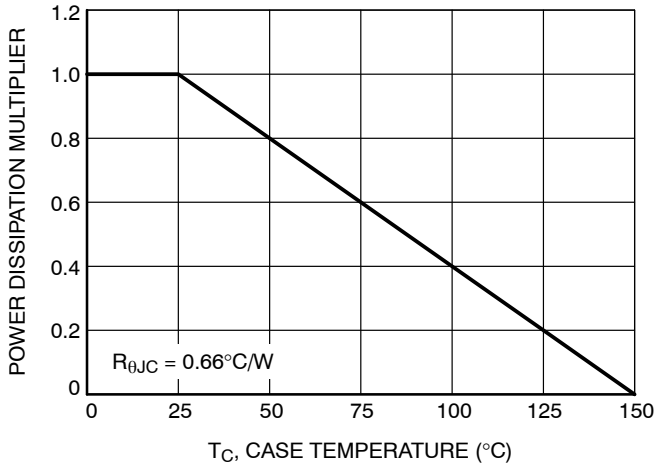
**Figure 3. Timing Measurement Variable Definition**

**Table 8. PARAMETER OF SWITCHING CHARACTERISTICS**

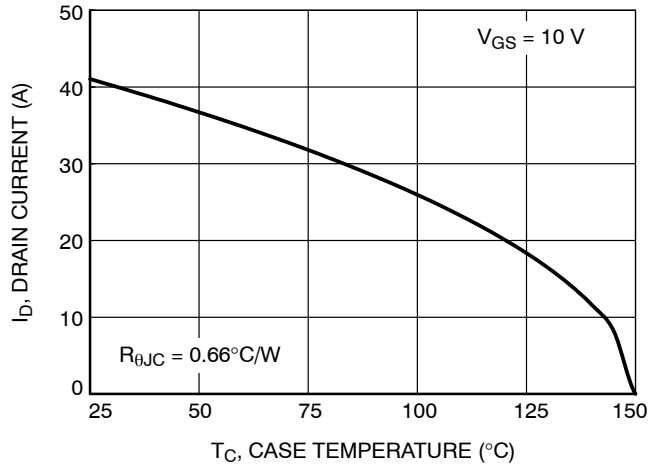
|                                 |   |
|---------------------------------|---|
| Turn-On Delay ( $t_{d(on)}$ )   | This is the time needed to charge the input capacitance, $C_{iss}$ , before the load current $I_D$ starts flowing. The measurement conditions are described in the Table 3. For signal definition please check Figure 3 above.  |
| Rise Time ( $t_r$ )             | The rise time is the time to discharge output capacitance, $C_{oss}$ . After that time the MOSFET conducts the given load current $I_D$ . The measurement conditions are described in the Table 3. For signal definition please check Figure 3 above.                                 |
| Turn-On Time ( $t_{on}$ )       | Is the sum of turn-on-delay and rise time   |
| Turn-Off Delay ( $t_{d(off)}$ ) | $t_{d(off)}$ is the time to discharge $C_{iss}$ after the MOSFET is turned off. During this time the load current $I_D$ is still flowing. The measurement conditions are described in the Table 3. For signal definition please check Figure 3 above.                                 |
| Fall Time ( $t_f$ )             | The fall time, $t_f$ , is the time to charge the output capacitance, $C_{oss}$ . During this time the load current drops down and the voltage $V_{DS}$ rises accordingly. The measurement conditions are described in the Table 3. For signal definition please check Figure 3 above. |
| Turn-Off Time ( $t_{off}$ )     | Is the sum of turn-off-delay and fall time  |

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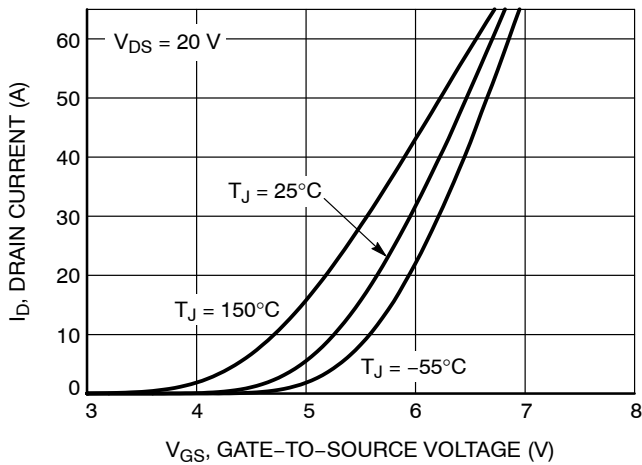
## TYPICAL CHARACTERISTICS – MOSFETs



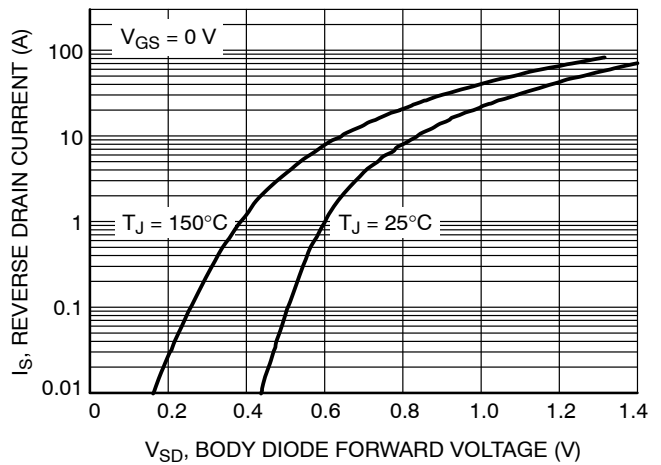
**Figure 4. Normalized Power Dissipation vs. Case Temperature**



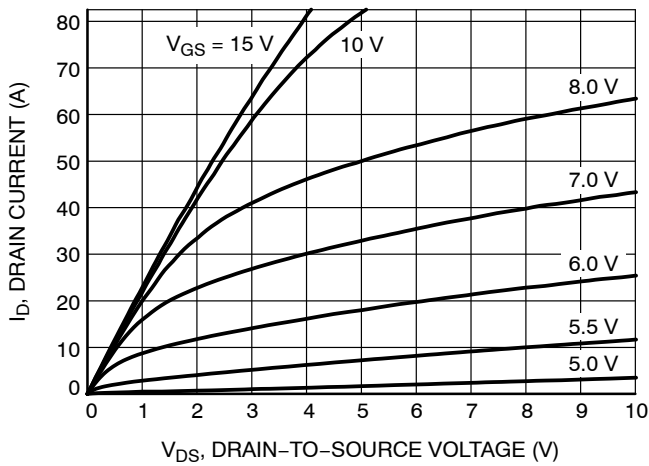
**Figure 5. Maximum Continuous  $I_D$  vs. Case Temperature**



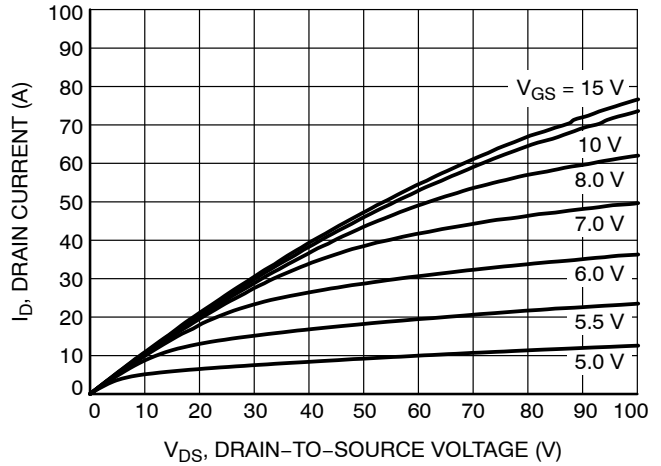
**Figure 6. Transfer Characteristics**



**Figure 7. Forward Diode**



**Figure 8. On Region Characteristics ( $25^{\circ}\text{C}$ )**

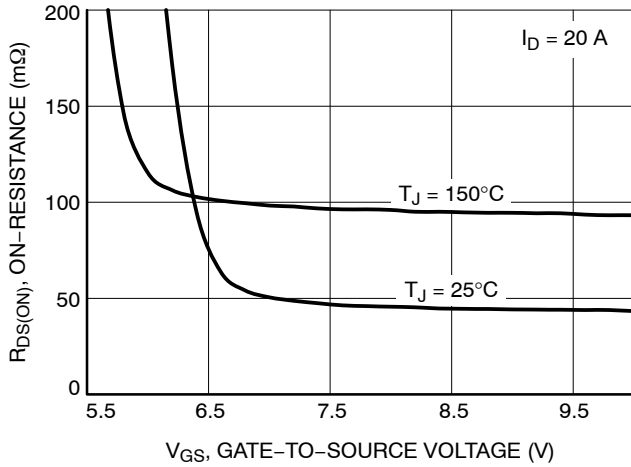


**Figure 9. On Region Characteristics ( $150^{\circ}\text{C}$ )**

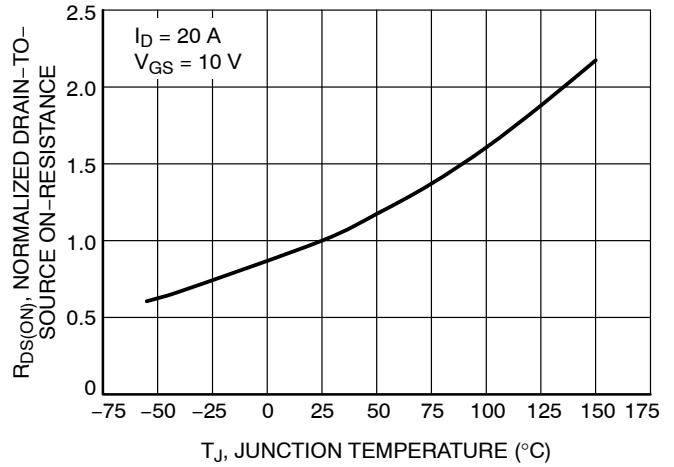


# FAM65CR51ADZ1, FAM65CR51ADZ2

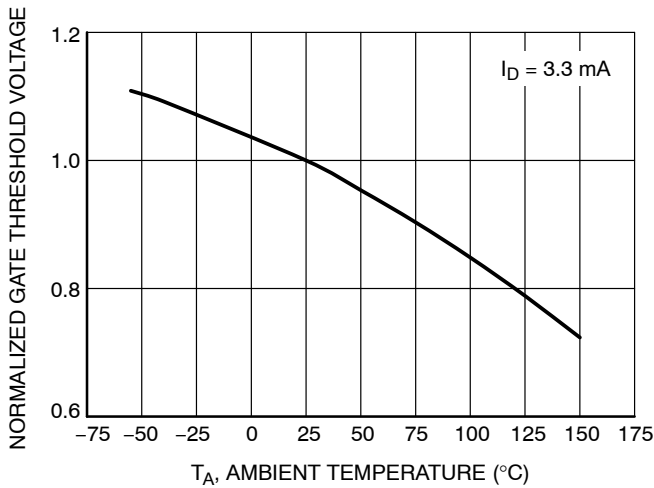
## TYPICAL CHARACTERISTICS – MOSFETS



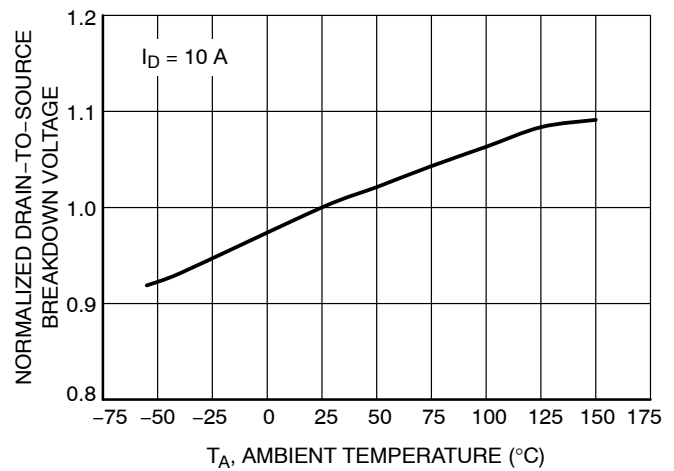
**Figure 10. On-Resistance vs. Gate-to-Source Voltage**



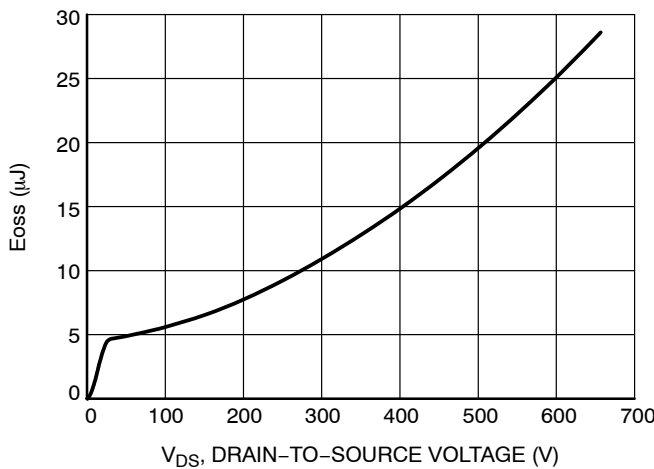
**Figure 11.  $R_{DS(norm)}$  vs. Junction Temperature**



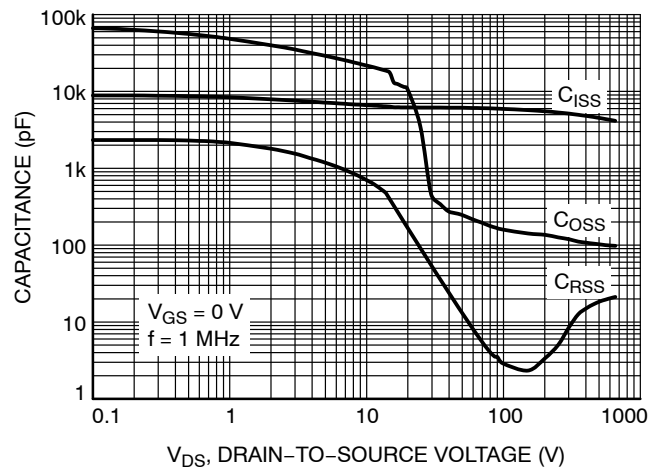
**Figure 12. Normalized Gate Threshold Voltage vs. Temperature**



**Figure 13. Normalized Breakdown Voltage vs. Temperature**



**Figure 14.  $E_{oss}$  vs. Drain-to-Source Voltage**



**Figure 15. Capacitance Variation**

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## TYPICAL CHARACTERISTICS – MOSFETs

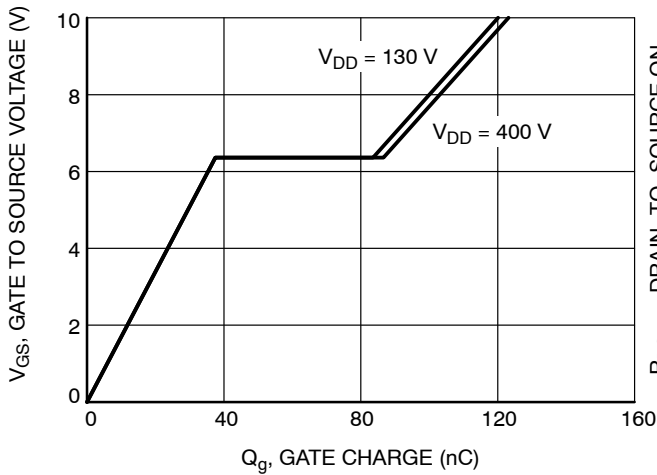


Figure 16. Gate Charge Characteristics

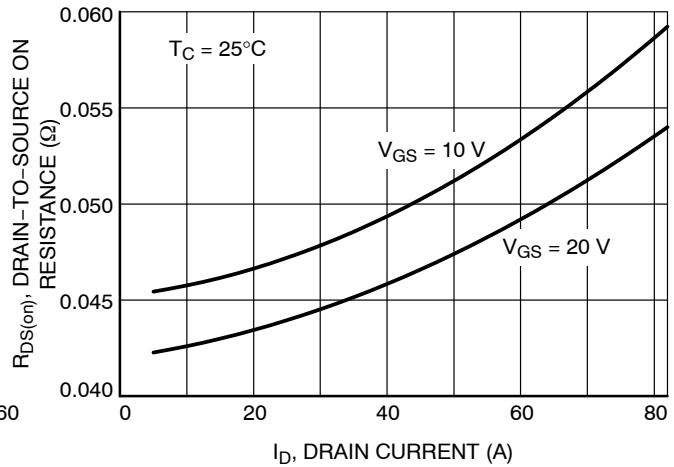


Figure 17. ON-Resistance Variation with Drain Current and Gate Voltage

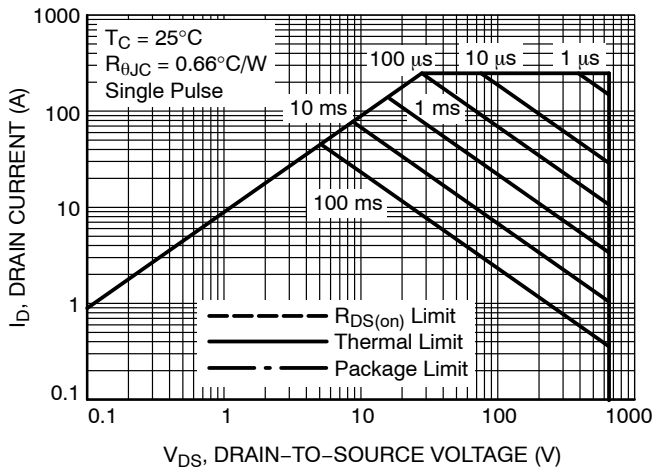


Figure 18. Safe Operating Area

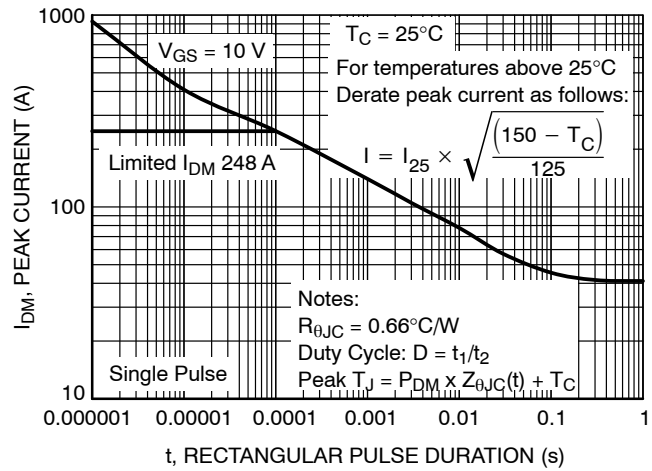


Figure 19. Peak Current Capability

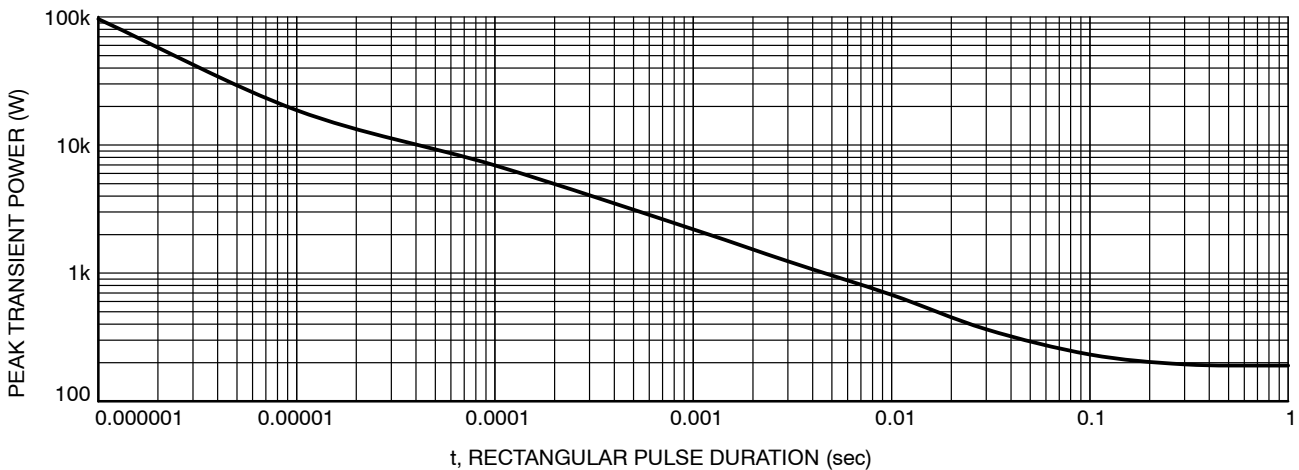
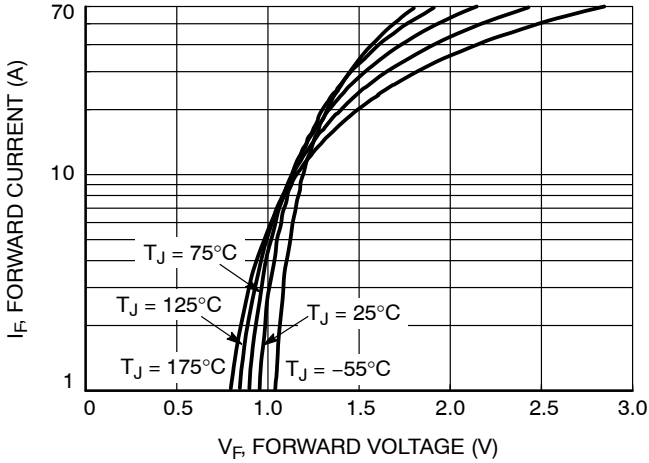


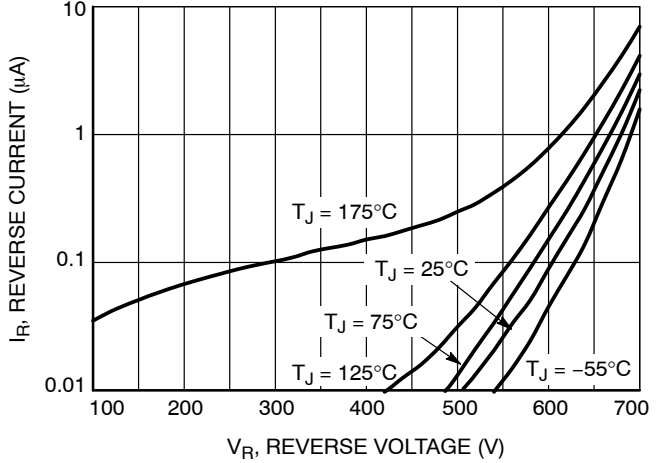
Figure 20. Peak Power

# FAM65CR51ADZ1, FAM65CR51ADZ2

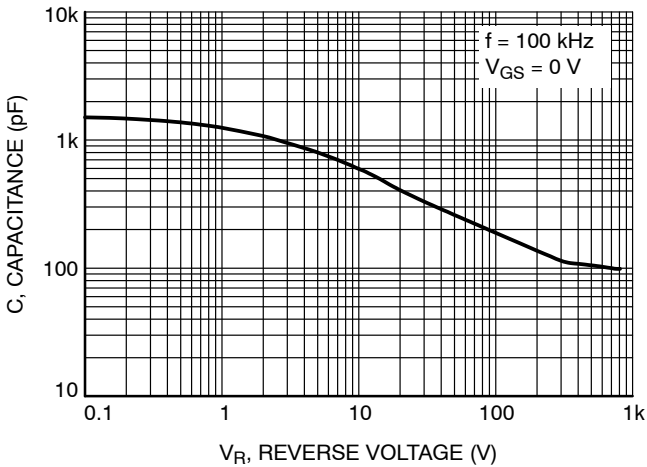
## TYPICAL CHARACTERISTICS – DIODES



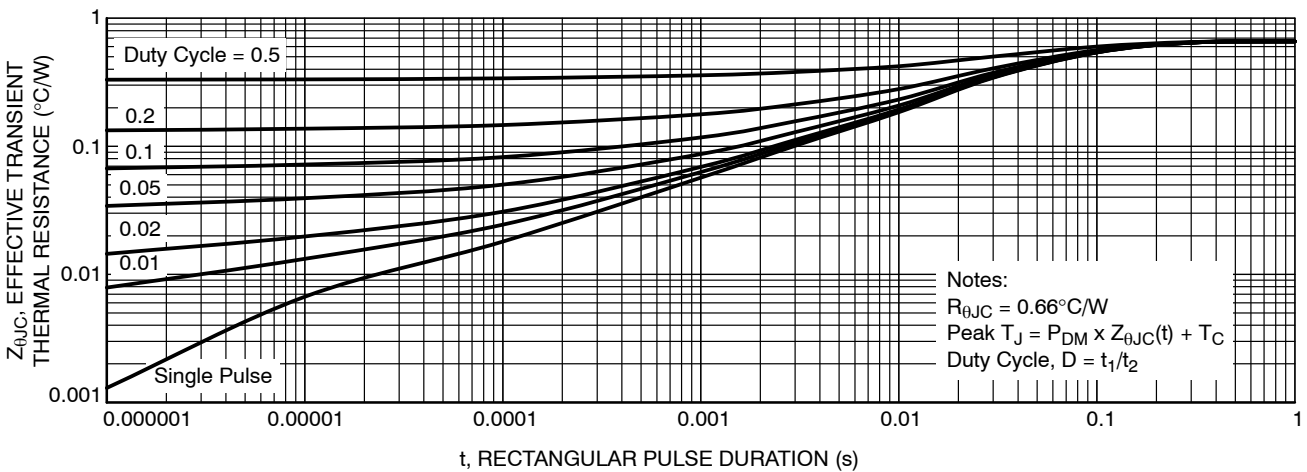
**Figure 21. Typical Forward Voltage Drop vs. Forward Current**



**Figure 22. Typical Reverse Current vs. Reverse Voltage**



**Figure 23. Capacitance**



**Figure 24. Transient Thermal Impedance**

# MECHANICAL CASE OUTLINE

## PACKAGE DIMENSIONS

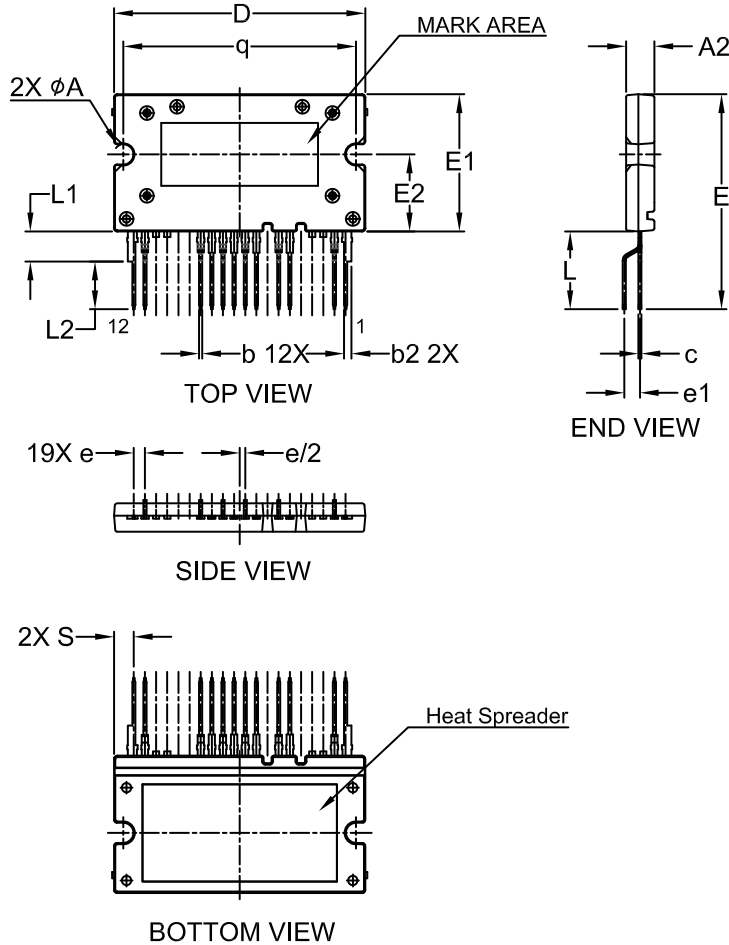
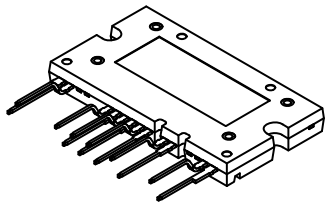


### APMCD-A16 / 12LD, AUTOMOTIVE MODULE

#### CASE MODGG

#### ISSUE C

DATE 03 NOV 2021

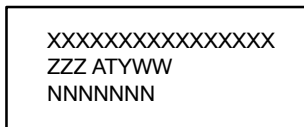


#### NOTES:

1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2009.
2. CONTROLLING DIMENSION: MILLIMETERS
3. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH AND TIE BAR EXTRUSIONS.

| DIM | MILLIMETERS |       |       |
|-----|-------------|-------|-------|
|     | MIN.        | NOM.  | MAX.  |
| A2  | 4.30        | 4.50  | 4.70  |
| b   | 0.45        | 0.50  | 0.60  |
| b2  | 1.15        | 1.20  | 1.30  |
| c   | 0.45        | 0.50  | 0.60  |
| D   | 39.90       | 40.10 | 40.30 |
| E   | 33.80       | 34.30 | 34.80 |
| E1  | 21.70       | 21.90 | 22.10 |
| E2  | 12.10       | 12.30 | 12.50 |
| e   | 1.478       | 1.778 | 2.078 |
| e1  | 2.20        | 2.50  | 2.80  |
| L   | 12.10       | 12.40 | 12.70 |
| L1  | 4.80 REF    |       |       |
| L2  | 7.30        | 7.60  | 7.90  |
| q   | 36.85       | 37.10 | 37.35 |
| S   | 3.159 REF   |       |       |
| φA  | 3.00        | 3.20  | 3.40  |

#### GENERIC MARKING DIAGRAM\*



XXXX = Specific Device Code  
 ZZZ = Lot ID  
 AT = Assembly & Test Location  
 Y = Year  
 WW = Work Week  
 NNN = Serial Number

\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "μ", may or may not be present. Some products may not follow the Generic Marking.

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# MECHANICAL CASE OUTLINE

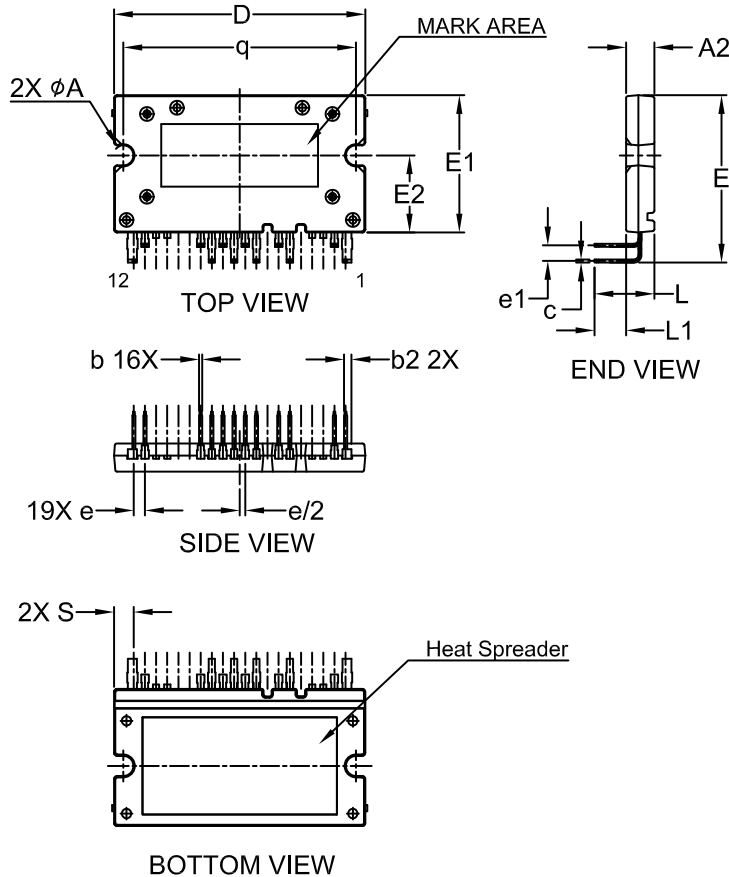
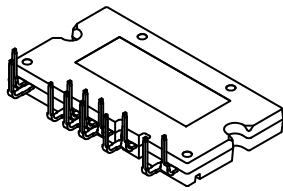
## PACKAGE DIMENSIONS



### APMCD-B16 / 12LD, AUTOMOTIVE MODULE

CASE MODGK  
ISSUE D

DATE 04 NOV 2021

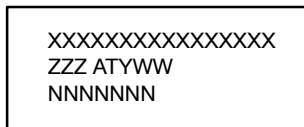


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|-----|-------------|-------|-------|
|     | MIN.        | NOM.  | MAX.  |
| A2  | 4.30        | 4.50  | 4.70  |
| b   | 0.45        | 0.50  | 0.60  |
| b2  | 1.15        | 1.20  | 1.30  |
| c   | 0.45        | 0.50  | 0.60  |
| D   | 39.90       | 40.10 | 40.30 |
| E   | 26.20       | 26.70 | 27.20 |
| E1  | 21.70       | 21.90 | 22.10 |
| E2  | 12.10       | 12.30 | 12.50 |
| e   | 1.478       | 1.778 | 2.078 |
| e1  | 2.20        | 2.50  | 2.80  |
| L   | 9.20        | 9.55  | 9.90  |
| L1  | 4.70        | 5.05  | 5.40  |
| q   | 36.85       | 37.10 | 37.35 |
| S   | 3.159 REF   |       |       |
| φA  | 3.00        | 3.20  | 3.40  |

#### GENERIC MARKING DIAGRAM\*



XXXX = Specific Device Code  
 ZZZ = Lot ID  
 AT = Assembly & Test Location  
 Y = Year  
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\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "μ", may or may not be present. Some products may not follow the Generic Marking.

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